



# RADIO TEST REPORT

**Test Report No. : 27JE0092-HO-A**

**Applicant** : **Sony Computer Entertainment Inc.**  
**Type of Equipment** : **PSP**  
**Model No.** : **PSP-2001**  
**FCC ID** : **AK8PSP2001**  
**Test standard** : **FCC Part 15 Subpart C  
Section 15.207, Section 15.247: 2007**  
**Test Result** : **Complied**

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This equipment is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.

**Date of test:** May 24, 30 and 31, 2007

**Tested by:** K. Adachi T. Shimada  
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NVLAP LAB CODE: 200572-0

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\*As for the range of Accreditation in NVLAP, you may refer to the WEB address, <http://uljapan.co.jp/emc/nvlap.htm>

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## **SECTION 1: Client information**

Company Name	Sony Computer Entertainment Inc.
Brand name	Sony
Address	2-6-21 Minami-Aoyama, Minato-ku, Tokyo, 107-0062, Japan
Telephone Number	+81-3-6483-8625
Facsimile Number	+81-3-6483-8626
Contact Person	Tatsuya Suzuki

## **SECTION 2: Equipment under test (E.U.T.)**

### **2.1 Identification of E.U.T.**

Type of Equipment	PSP
Model No.	PSP-2001
Serial No.	03-TSP1200H-0000114-PSPXXXX for Conducted / Radiated Emissions 03-TSP1200H-0000120-PSPXXXX for Antenna Terminal Conducted Test
Country of Manufacture	Japan
Condition of EUT	Production prototype (Not for sale: This sample is equivalent to mass-produced items.)
Receipt Date of Sample	May 8, 2007

### **2.2 Product Description**

#### Radio Specification

#### Wireless LAN Module (IEEE802.11b)

Equipment Type	Transceiver
Frequency of Operation	2412-2462 MHz
Clock Frequency	40MHz
ITU Code	G1D
Type of Modulation	DSSS
Method of frequency generation	Crystal
Antenna model	HFS36-SO01
Antenna type	Inverted F antenna
Antenna Gain	+3.5 dBi (Max.)

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### **SECTION 3: Test specification, procedures & results**

#### **3.1 Test Specification**

Test Specification : FCC Part15 Subpart C : 2007  
Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators  
Section 15.207 Conducted limits : 2007  
Section 15.247 Operation within the bands 902-928MHz,  
2400-2483.5MHz, and 5725-5850MHz : 2007

#### **FCC 15.31 (e)**

This EUT provides stable voltage (DC3.1V/1.9V) constantly to RF Module regardless of input voltage. (For details, refer to Block Diagram for the product.) Therefore, this EUT complies with the requirement.

#### **FCC Part 15.203 Antenna requirement**

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.2 Procedures and results

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	Conducted emission	FCC: ANSI C63.4:2003 7. AC powerline conducted emission measurements ----- IC: RSS-Gen 7.2.2	FCC: Section 15.207 ----- IC: RSS-Gen 7.2.2	-	N/A	19.1dB 14.08389MHz, L, AV	Complied
2	6dB Bandwidth	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators ----- IC: RSS-Gen 4.4.2	FCC: Section 15.247(a)(2) ----- IC: RSS-210 A8.2(1)	Conducted	N/A	See data.	Complied
3	Maximum Peak Output Power	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators ----- IC: RSS-Gen 4.6	FCC: Section 15.247(b)(3) ----- IC: RSS-210 A8.4(4)	Conducted	N/A		Complied
4	Restricted Band Edges	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators ----- IC: -	FCC: Section 15.247 (d) ----- IC: RSS-210 A8.5	Conducted/ Radiated	N/A		Complied
5	Power Density	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators ----- IC: -	FCC: Section 15.247 (e) ----- IC: RSS-210 A8.2(2)	Conducted	N/A		Complied
6	Spurious Emission	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators ----- IC: RSS-Gen 4.7 RSS-Gen 4.8	FCC: Section 15.247(d) ----- IC: RSS-210 A8.5 RSS-Gen 7.2.1 and 7.2.3	Conducted/ Radiated	N/A		(Tx) 4.9dB 62.265MHz Vertical (Rx) 5.0dB 62.256MHz Vertical

Note: UL Japan, Inc.'s EMI Work Procedures No.QPM05 and QPM15.

\*These tests were also referred to "Guidance on Measurement of Digital Transmission Systems Operating under Section 15.247".

\*These tests were performed without any deviations from test procedure except for additions or exclusions.

### 3.3 Addition to standards

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	99% Occupied Band Width	RSS-Gen 4.4.1	-	Conducted	N/A	N/A	N/A

### 3.4 Uncertainty

#### Conducted Emission

The measurement uncertainty (with a 95% confidence level) for this test is  $\pm 2.66$ dB.  
The data listed in this test report has enough margin, more than the site margin.

#### Spurious Emission (Radiated)

The measurement uncertainty (with a 95% confidence level) for this test using Biconical antenna is  $\pm 4.59$ dB(3m).  
The measurement uncertainty (with a 95% confidence level) for this test using Logperiodic antenna is  $\pm 4.62$ dB(3m).  
The measurement uncertainty (with a 95% confidence level) for this test using Horn antenna is  $\pm 5.27$ dB.  
The data listed in this test report has enough margin, more than the site margin.

#### Other test except Conducted Emission and Spurious Emission (Radiated)

The measurement uncertainty (with a 95% confidence level) for this test is  $\pm 3.0$ dB.

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### 3.5 Test Location

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	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	IC4247A	19.2 x 11.2 x 7.7m	7.0 x 6.0m	Preparation room
No.2 semi-anechoic chamber	655103	IC4247A-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	IC4247A-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	IC4247A-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	-
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	N/A	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-

\* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

### 3.6 Test set up, Test instruments and Data of EMI

Refer to APPENDIX 1 to 3.

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## **SECTION 4: Operation of E.U.T. during testing**

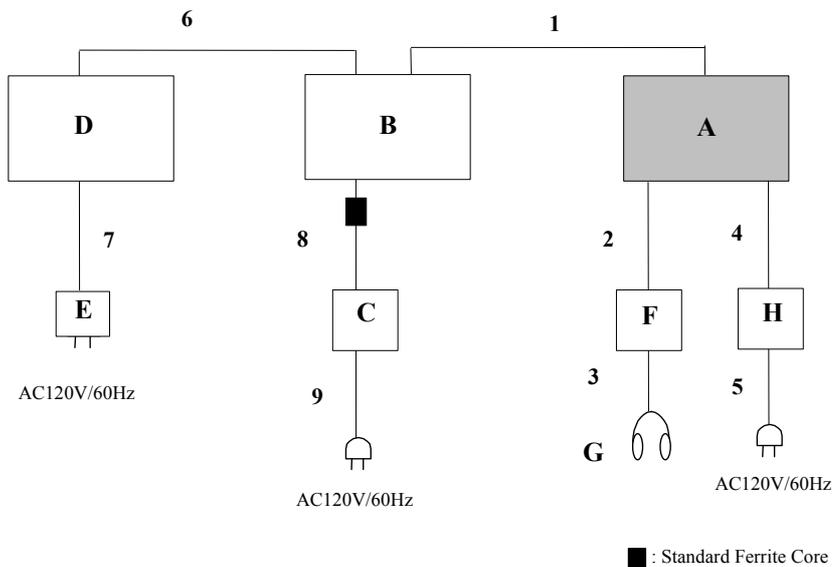
### **4.1 Operating Modes**

The mode used for test :

Transmitting mode 11b (CCK 11Mbps (Worst), Packet type: Maximum, Payload: PN9)  
- Low Channel : 2412MHz(Ch1)  
- Mid Channel : 2437MHz(Ch6)  
- High Channel : 2462MHz(Ch11)  
Receiving mode 11b  
- Mid Channel : 2437MHz(Ch6)

\*As a result of preliminary test, the formal test was performed with the above modes, which had the maximum rated power.

### **4.2 Configuration and peripherals**



\* Cabling and setup were taken into consideration and test data was taken under worse case conditions.

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**Description of EUT and Support equipment**

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	PSP	PSP-2001	03-TSP1200H-0000114-PSPXXXX *1)	Sony Computer Entertainment	EUT
			03-TSP1200H-0000120-PSPXXXX *2)		
B	Note PC	2371-4WJ	KV-0445503/12	IBM	-
C	AC Adapter	02K6808	11502K6808Z1Z89H4BJ6YB	IBM	-
D	Hub	FX-05Mini	37GC00419A	PLANEX	-
E	Adapter for Hub	RHF-050080-1	0709G	PLENEX	-
F	HP Remote Controller	PSP-S120	-	MITSUMI	-
G	Headphones	PSP-130	-	SONY	-
H	AC Adapter	ADP-597SR	06121020036CU	MITSUMI	-

\*1) Used for Conducted / Radiated Emissions.

\*2) Used for Antenna Terminal Conducted Test.

**List of cables used**

No.	Name	Length (m)	Shield	
			Cable	Connector
1	USB Cable	0.5	Shielded	Shielded
2	HP Remote Control Cable	0.8	Unshielded	Unshielded
3	Headphones Cable	1.1	Unshielded	Unshielded
4	DC Cable	1.5	Unshielded	Unshielded
5	AC Cable	1.5	Unshielded	Unshielded
6	LAN Cable	3.0	Unshielded	Unshielded
7	DC Cable	1.8	Unshielded	Unshielded
8	DC Cable	1.8	Unshielded	Unshielded
9	AC Cable	1.0	Unshielded	Unshielded

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## **SECTION 5: Conducted Emission**

### **Test Procedure and conditions**

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 80cm above the conducting ground plane. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center.

#### For the tests on EUT with other peripherals (as a whole system)

I/O cable and AC cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. All unused 50ohm connectors of the LISN(AMN) were resistivity terminated in 50ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber or a Measurement Room.

The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

**Detector** : quasi-peak and average detector (IF BW 9 kHz)  
**Measurement range** : 0.15-30MHz  
**Test data** : APPENDIX 2  
**Test result** : Pass

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## **SECTION 6: Spurious Emission**

### **[Conducted]**

#### **Test Procedure**

The Out of Band Emission was measured with a spectrum analyzer connected to the antenna port.

**Test data** : APPENDIX 2

**Test result** : Pass

### **[Radiated]**

#### **Test Procedure**

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 80cm above the conducting ground plane. The Radiated Electric Field Strength intensity has been measured in a Semi Anechoic Chamber with a ground plane and at a distance of 3m(Below 10GHz) and 1m(Upper 10GHz).

The height of the measuring varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

The result also satisfied with the general limits specified in section 15.209(a).

Frequency	Below 1GHz	Above 1GHz
Instrument used	Test Receiver	Spectrum Analyzer
Detector	QP: BW 120kHz	PK: RBW:1MHz/VBW: 1MHz
IF Bandwidth		AV: RBW:1MHz/VBW:10Hz

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

**Test data** : APPENDIX 2

**Test result** : Pass

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## **SECTION 7: Bandwidth**

### **Test Procedure**

The bandwidth was measured with a spectrum analyzer connected to the antenna port.

**Test data** : APPENDIX 2  
**Test result** : Pass

## **SECTION 8: Maximum Peak Output Power**

### **Test Procedure**

The Maximum Peak Output Power was measured with a power meter (tested bandwidth: 50MHz) connected to the antenna port.

It was measured based on "Power Output Option 1" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

**Test data** : APPENDIX 2  
**Test result** : Pass

## **SECTION 9: Peak Power Density**

[Conducted]

### **Test Procedure**

The Peak Power Density was measured with a spectrum analyzer connected to the antenna port.

It was measured based on "PSD Option 1" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

**Test data** : APPENDIX 2  
**Test result** : Pass

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